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## Vernachlässigte Effekte mit erheblichem Einfluss auf die Verluste von Induktivitäten

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# Agenda

Core Losses under DC Bias Condition

- Relaxation Effects in Magnetic Materials
- Losses of Gapped Tape Wound Cores



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## Core Losses under DC Bias Condition Motivation



According to the Steinmetz Equation core losses should be the same for both loops, but ...





## Core Losses under DC Bias Condition Measurement Results (1)

#### **Results**

Ferrite EPCOS N87







## Core Losses under DC Bias Condition Measurement Results (2)

#### **Results**

Ferrite EPCOS N87







## Core Losses under DC Bias Condition Measurement Results (3)

#### **Results**

Ferrite EPCOS N87





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## **Core Losses under DC Bias Condition** Model Derivation (1) : Motivation

#### Copy from Data Sheet EPCOS N87



How could the effect of a DC bias be described in a data sheet?

Idea: to publish Steinmetz parameters as a function of the premagnetization  $H_{DC}$ 





## **Core Losses under DC Bias Condition** Model Derivation (2) : Power Law?

Can core losses under DC Bias condition still be described by a power law (Potenzgesetz)?



#### **Measurement Results**

Steinmetz Equation  $P = k f^{\alpha} B^{\beta}$ 





## **Core Losses under DC Bias Condition** Model Derivation (3) : What Parameters Depend on $H_{DC}$



**Steinmetz Equation** 

 $P = k f^{\alpha} B^{\beta}$ 

k depends on  $H_{\rm DC}$ 

 $\beta$  depends on  $H_{\rm DC}$ .

$$\frac{P}{P_0} = f(\Delta B)$$





## **Core Losses under DC Bias Condition** Model Derivation (4) : What Parameters Depend on $H_{DC}$



**Steinmetz Equation** 

 $P = k f^{\alpha} B^{\beta}$ 

 $\alpha$  is independent of  $H_{\rm DC}$ 





## **Core Losses under DC Bias Condition** Model Derivation (5) : Steinmetz Parameters as a Function of *H*<sub>DC</sub>







## **Core Losses under DC Bias Condition** The Steinmetz Premagnetization Graph (SPG)





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## **Core Losses under DC Bias Condition** SPG – An Example

#### **Buck Converter**



$V_{ m in}$ / $V_{ m out}$	12 V / 6 V
f	100 kHz
Р	$2\mathrm{W}$
$I_{\rm load}$	0.33 A
L	150 μH (EPCOS N87; R25; N=8)
	(core part number: B64290L618X87 [19])

#### Steps towards accurate core losses:

- Calculate magnetic operating point:  $H_{DC} = 44 \text{ A/m} / \Delta B = 73 \text{ mT}.$
- Extract Steinmetz parameters:  $\alpha = 1.25$ ,  $\beta = 2.46$ , k = 15.9
- Calculate  $k_i$  (iGSE)
- Adjust  $k_i$  and  $\beta$  according to the SPG:  $\beta = 2.56$ ,  $k_i = 3.28$
- Calculate core losses with the iGSE.





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## Relaxation effect Motivation (1)

#### Waveform



**iGSE** [5]

$$P_{\rm v} = \frac{1}{T} \int_{0}^{T} k_{i} \left| \frac{\mathrm{d}B}{\mathrm{d}t} \right|^{\alpha} \left( \Delta B \right)^{\beta - \alpha} \mathrm{d}t$$

#### Conclusion

No losses in the phase of constant flux! True?





## Relaxation effect Motivation (2)

#### Waveform





#### Conclusion







# Relaxation effect

#### (Static) hysteresis loss

- Rate-independent BH Loop.
- Loss energy per cycle is constant.
- Irreversible changes each within a small region of the lattice (Barkhausen jumps).
- These rapid, irreversible changes are produced by relatively strong local fields within the material.



- Eddy current losses
- Residual Losses Relaxation losses



# Relaxation effect

- (Static) hysteresis loss
- Eddy current losses
  - Depending on material conductivity and core shape.
  - Very low in ferrites.
  - Affect BH loop.
- Residual Losses Relaxation losses

 $\phi \frac{d\phi}{dt}$ 



 $L_{11} - M \approx 0$  $L_{22} - M = 0$ 



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→ Eddy Currents may be discontinuous

#### **Measurements**



b)

 $\phi_d = \frac{d\phi_d}{dt}$ 

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# Relaxation effect

- (Static) hysteresis loss
- Eddy current losses
- Residual Losses Relaxation losses
  - Reestablishment of a thermal equilibrium is governed by relaxation processes.
  - Restricted domain wall motion.









## Relaxation effect Model Derivation 1 (1)

#### Waveform



#### Loss Energy per Cycle



#### **Derivation (1)**

Relaxation loss energy can be described with



au is independent of operating point.

How to determine  $\Delta E$ ?





## Relaxation effect Model Derivation 1 (2)

#### **∆***E* – Measurements



#### Waveform





 $\rightarrow \Delta E$ follows a power function!









## Relaxation effect Model Derivation 1 (3)



**Model Part 1** 

$$P_{v} = \frac{1}{T} \int_{0}^{T} k_{i} \left| \frac{\mathrm{d}B}{\mathrm{d}t} \right|^{\alpha} (\Delta B)^{\beta - \alpha} \mathrm{d}t + \sum_{l=1}^{n} P_{\mathrm{r}l}$$

$$P_{\mathrm{r}l} = \frac{1}{T} k_{\mathrm{r}} \left| \frac{\mathrm{d}}{\mathrm{d}t} B(t) \right|^{\alpha_{\mathrm{r}}} (\Delta B)^{\beta_{\mathrm{r}}} \left( 1 - \mathrm{e}^{-\frac{t_{\mathrm{l}}}{\tau}} \right)$$





## Relaxation effect Model Derivation 2 (1)

#### Waveform



#### **Power Loss**



#### **Explanation**

- 1) For values of *D* close to 0 or close to 1 a loss underestimation is expected when calculating losses with iGSE (no relaxation losses included).
- 2) For values of *D* close to 0.5 the iGSE is expected to be accurate.
- 3) Hence, adding the relaxation term leads to the upper loss limit, while the iGSE represents the lower loss limit.
- 4) Losses are expected to be in between the two limits, as has been confirmed with measurements.





## Relaxation effect Model Derivation 2 (2)

#### Waveform



#### **Power Loss**



#### **Model Adaption**

$$P_{v} = \frac{1}{T} \int_{0}^{T} k_{i} \left| \frac{\mathrm{d}B}{\mathrm{d}t} \right|^{\alpha} \left( \Delta B \right)^{\beta - \alpha} \mathrm{d}t + \sum_{l=1}^{n} Q_{\mathrm{r}l} P_{\mathrm{r}l}$$

 $Q_{r/}$  should be 1 for D = 0

 $Q_{r/}$  should be 0 for D = 0.5

 $Q_{r/}$  should be such that calculation fits a triangular waveform measurement.

$$Q_{\mathrm{r}l} = \mathrm{e}^{-q_{\mathrm{r}} \left| \frac{\mathrm{d}B(t+)/\mathrm{d}t}{\mathrm{d}B(t-)/\mathrm{d}t} \right|} \left( = \mathrm{e}^{-q_{\mathrm{r}} \frac{D}{1-D}} \right)$$





## Relaxation effect Model Derivation 2 (3)

#### Waveform





![](_page_24_Figure_6.jpeg)

![](_page_25_Picture_1.jpeg)

## Relaxation effect New Core Loss Model

The improved-improved Generalized Steinmetz Equation (i<sup>2</sup>GSE)

$$P_{\rm v} = \frac{1}{T} \int_{0}^{T} k_{i} \left| \frac{\mathrm{d}B}{\mathrm{d}t} \right|^{\alpha} (\Delta B)^{\beta - \alpha} \mathrm{d}t + \sum_{l=1}^{n} Q_{\rm rl} P_{\rm rl}$$

with

$$P_{\mathrm{r}l} = \frac{1}{T} k_{\mathrm{r}} \left| \frac{\mathrm{d}}{\mathrm{d}t} B(t) \right|^{\alpha_{\mathrm{r}}} (\Delta B)^{\beta_{\mathrm{r}}} \left( 1 - \mathrm{e}^{-\frac{t_{\mathrm{l}}}{\tau}} \right)$$

and

$$Q_{\rm rl} = {\rm e}^{-q_{\rm r} \left| \frac{{\rm d}B(t+)/{\rm d}t}{{\rm d}B(t-)/{\rm d}t} \right|}$$

![](_page_25_Picture_9.jpeg)

![](_page_26_Picture_0.jpeg)

![](_page_26_Picture_1.jpeg)

## **Relaxation effect** Example: Dual Active Bridge

#### **Schematic**

![](_page_26_Figure_4.jpeg)

#### Waveform & Model

![](_page_26_Figure_6.jpeg)

![](_page_26_Figure_7.jpeg)

#### i<sup>2</sup>GSE Results

![](_page_26_Figure_9.jpeg)

#### **Results from [6]**

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In [6] a very similar example has been calculated. For increasing zero voltage periods, the calculated core losses start deviating from the measured core losses. The reason becomes clear with the new approach i<sup>2</sup>GSE and the calculation can be improved. In Figure on the right the losses are normalized to calculation with original Steinmetz Equation (OSE).

![](_page_26_Figure_12.jpeg)

![](_page_27_Picture_1.jpeg)

# Agenda

- Core Losses under DC Bias Condition
- Relaxation Effects in Magnetic Materials
- Losses of Gapped Tape Wound Cores

![](_page_28_Picture_0.jpeg)

![](_page_28_Picture_1.jpeg)

## Losses of Gapped Tape Wound Cores Motivation

![](_page_28_Picture_3.jpeg)

#### Losses in gapped tape wound cores higher than expected!

(gapped tape wound cores such as amorphous or nanocrystalline iron materials).

Left figure from www.vacuumschmelze.de

![](_page_29_Picture_1.jpeg)

## Losses of Gapped Tape Wound Cores Cause 1 : Interlamination Short Circuits

#### **Machining process**

Surface short circuits introduced by machining. Particular a problem in in-house production.

![](_page_29_Picture_5.jpeg)

After treatment may reduce this effect. At ETH, a core was put in an 40% ferric chloride (Eisenchlorid FeCl<sub>3</sub>) solution after cutting, which substantially decreased the core losses [3].

![](_page_30_Picture_1.jpeg)

## Losses of Gapped Tape Wound Cores Cause 2 : Orthogonal Flux Lines (1)

Experiment that illustrates well the loss increase due to a flux that is orthogonal to the lamination layers (1).

![](_page_30_Figure_4.jpeg)

**Horizontal Displacement** 

![](_page_30_Picture_6.jpeg)

![](_page_31_Picture_1.jpeg)

## Losses of Gapped Tape Wound Cores Cause 2 : Orthogonal Flux Lines (2)

# Experiment that illustrates well the loss increase due to a flux that is orthogonal to the lamination layers (2).

#### **Core Loss Results**

![](_page_31_Figure_5.jpeg)

![](_page_32_Picture_1.jpeg)

## Losses of Gapped Tape Wound Cores Cause 2 : Orthogonal Flux Lines (3)

#### Core loss increase due to leakage flux in transformers.

#### **Measurement Set Up**

![](_page_32_Picture_5.jpeg)

#### Results

![](_page_32_Figure_7.jpeg)

![](_page_33_Picture_1.jpeg)

## Losses of Gapped Tape Wound Cores Cause 2 : Orthogonal Flux Lines (4)

In [4] a core loss increase with increasing air gap length has been observed.

![](_page_33_Figure_4.jpeg)

Fig.1 Core loss per cycle W/f in FINEMET, Fe-based amorphous, and ferrite cut cores as a function of inverse of the effective permeability  $\mu_r$ .

![](_page_33_Picture_6.jpeg)

Fig.2 Schematic representation of in-plane eddy current generated by leakage flux normal to ribbon surfaces.

#### Figures from [4].

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### **Conclusion & Outlook**

#### The following effects have been discussed:

#### Core Losses under DC Bias Condition [1]

Until core manufacturers provide data about losses under DC bias condition, measuring core losses is indispensable.

#### **Relaxation Effects in Magnetic Materials [2]**

The model i<sup>2</sup>GSE takes such effects into account.

#### Losses of Gapped Tape Wound Cores [3,4]

To the speaker's knowledge, there exists no approach which allows to analytically describe the presented effects.

![](_page_35_Picture_0.jpeg)

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![](_page_35_Picture_2.jpeg)

## Thank you !

## Do you have any questions ?

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### References

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